

Microwire BUS Serial EEPROMs

Supply voltage 1.8V~5.5V Operating temperature –40°C~+85°C type

BR93L46-W, BR93L56-W, BR93L66-W, BR93L76-W, BR93L86-W

Description

BR93LDD-W series is a serial EEPROM of serial 3-line interface method.

Features

• 3-line communications of chip select, serial clock, serial data input / output (the case where input and output are shared)

igh Reliability

- Actions available at high speed 2MHz clock (2.5 ~ 5.5V)
- Speed write available (write time 5 ms max.)
- Same package and pin layout from 1Kbit to 16Kbit
- 1.8 ~ 5.5V single power source action
- Highly reliable connection by Au pad and Au wire
- Address auto increment function at read action
- Write mistake prevention function
 - Write prohibition at power on
 - Write prohibition by command code
 - Write mistake prevention function at low voltage
- Program cycle auto delete and auto end function
- Program condition display by READY / BUSY
- Low current consumption
 - At write action (at 5V) : 1.2mA (Typ.)
 - At read action (at 5V) : 0.3mA (Typ.)
 - At standby action (at 5V) : 0.1µA (Typ.) (CMOS input)
- TTL compatible input / output
- Compact package SOP8, SOP-J8, SSOP-B8, TSSOP-B8, MSOP8, TSSOP-B8J
- Data retention for 40 years
- Data rewrite up to 1,000,000 times
- Data at shipment all addresses FFFh

| Capacity | Bit format | Туре | Power source voltage | SOP8 | | SOP8 | | SOF | o-18 | SSO | P-B8 | TSSO | OP-B8 | MSOP8 | TSSOP-B8J |
|----------|--------------|-----------|----------------------|------|----|------|-----|-----|------|-----|------|------|-------|-------|-----------|
| | Package type | | | F | RF | FJ | RFJ | FV | RFV | FVT | RFVT | RFVM | RFVJ | | |
| 1Kbit | 64 × 16 | BR93L46-W | 1.8 ~ 5.5V | | | | | | | | | | | | |
| 2Kbit | 128 × 16 | BR93L56-W | 1.8 ~ 5.5V | | | | | | | | | • | | | |
| 4Kbit | 256 × 16 | BR93L66-W | 1.8 ~ 5.5V | | | | | | | | | • | • | | |
| 8Kbit | 512 × 16 | BR93L76-W | 1.8 ~ 5.5V | | | | | | | | | • | | | |
| 16Kbit | 1K × 16 | BR93L86-W | 1.8 ~ 5.5V | | | | | | | | | | | | |

BR93L Series

Absolute Maximum Ratings (Ta=25°C)

| Parameter | Symbol | Limits | Unit | |
|---------------------------|--------|----------------------|----------|----|
| Faiailletei | Symbol | LIMIUS | Unit | |
| Impressed voltage | Vcc | -0.3 ~ +6.5 | | V |
| | | SOP8 (F, RF) | 450 (*1) | |
| | | SOP-J8 (FJ, RFJ) | 450 (*2) | |
| Permissible dissipation | Pd | SSOP-B8 (FV, RFV) | 300 (*3) | mW |
| | | TSSOP-B8 (FVT, RFVT) | 330 (*4) | |
| | | MSOP8 (RFVM) | 310 (*5) | |
| | | TSSOP-B8J (RFVJ) | 310 (*6) | |
| Storage temperature range | Tstg | -65 ~ +125 | | °C |
| Action temperature range | Topr | -40 ~ +85 | | °C |
| Terminal voltage | - | -0.3 ~ Vcc+0.3 | | V |

Recommended action conditions

| Parameter | Symbol | Limits | Unit |
|----------------------|--------|-----------|------|
| Power source voltage | Vcc | 1.8 ~ 5.5 | V |
| Input voltage | Vin | 0 ~ Vcc | V |

* When using at Ta = 25°C or higher, 4.5mW (*1, *2), 3.0mW (*3), 3.3mW (*4),3.1mW (*5, *6) to be reduced per 1°C.

● Electrical characteristics (Unless otherwise specified, Ta=-40 ~ +85°C, Vcc=2.5 ~ 5.5V)

| Parameter | Symbol | Min. | Тур. | Max. | Unit | Conditions |
|-------------------------------|--------|---------|------|---------|------|--------------------------------|
| "L" input voltage 1 | VIL1 | -0.3 | - | +0.8 | V | 4.0V≤Vcc≤5.5V |
| "L" input voltage 2 | VIL2 | -0.3 | - | 0.2xVcc | V | Vcc≤4.0V |
| "H" input voltage 1 | VIH1 | 2.0 | - | Vcc+0.3 | V | 4.0V≤Vcc≤5.5V |
| "H" input voltage 2 | VIH2 | 0.7xVcc | - | Vcc+0.3 | V | Vcc≤4.0V |
| "L" output voltage 1 | Vol1 | 0 | - | 0.4 | V | lo∟=2.1mA, 4.0V≤Vcc≤5.5V |
| "L" output voltage 2 | Vol2 | 0 | - | 0.2 | V | Ιοι=100μΑ |
| "H" output voltage 1 | Voh1 | 2.4 | - | Vcc | V | Іон=-0.4mA, 4.0V≤Vсс≤5.5V |
| "H" output voltage 2 | Vон2 | Vcc-0.2 | - | Vcc | V | Іон=-100µА |
| Input leak current | lu | -1 | - | +1 | μA | VIN=0~VCC |
| Output leak current | Ilo | -1 | - | +1 | μA | Vout=0~Vcc, CS=0V |
| | Icc1 | - | - | 3.0 | mA | fsк=2MHz, terw=5ms (WRITE) |
| Current consumption at action | Icc2 | - | - | 1.5 | mA | fsк=2MHz (READ) |
| | Іссз | - | - | 4.5 | mA | fsк=2MHz, terw=5ms (WRAL,ERAL) |
| Standby current | lsв | - | - | 2 | μA | CS=0V, DO=OPEN |

(Unless otherwise specified, Ta=-40 ~ +85 $^{\circ}$ C, Vcc=1.8 ~ 2.5V)

| Parameter | Symbol | Min. | Тур. | Max. | Unit | Conditions |
|-------------------------------|--------|---------|------|---------|------|------------------------------|
| "L" input voltage | VIL | -0.3 | - | 0.2xVcc | V | |
| "H" input voltage | Vih | 0.7xVcc | - | Vcc+0.3 | V | |
| "L" output voltage | Vol | 0 | - | 0.2 | V | Ιοι=100μΑ |
| "H" output voltage | Vон | Vcc-0.2 | - | Vcc | V | Іон=-100μА |
| Input leak current | Iц | -1 | - | +1 | μA | VIN=0~Vcc |
| Output leak current | Ilo | -1 | - | +1 | μA | Vout=0~Vcc, CS=0V |
| | Icc1 | - | - | 1.5 | mA | fsк=500kHz, te/w=5ms (WRITE) |
| Current consumption at action | Icc2 | - | - | 0.5 | mA | fsк=500kHz (READ) |
| | Іссз | - | - | 2 | mA | fsк=500kHz (WRAL,ERAL) |
| Standby current | lsв | - | - | 2 | μA | CS=0V, DO=OPEN |

Memory cell characteristics (Ta=25°C, Vcc=1.8 ~ 5.5V)

| Parameter | Min. | Тур. | Max. | Unit | | | | |
|---------------------------------|-----------|------|------|-------|--|--|--|--|
| Number of data rewrite times *1 | 1,000,000 | - | - | Times | | | | |
| Data hold years *1 | 40 | - | - | Years | | | | |
| | | | | | | | | |

*1 Not 100% TESTED

Action timing characteristics (Ta=-40 ~ +85°C, Vcc=2.5 ~ 5.5V)

| Parameter | Symbol | Min. | Тур. | Max. | Unit |
|--------------------------------------|------------------|------|------|------|------|
| SK frequency | fsк | - | - | 2 | MHz |
| SK "H" time | tsкн | 230 | - | - | ns |
| SK "L" time | t sĸ∟ | 230 | - | - | ns |
| CS "L" time | tcs | 200 | - | - | ns |
| CS setup time | tcss | 50 | - | - | ns |
| DI setup time | tois | 100 | - | - | ns |
| CS hold time | tсsн | 0 | - | - | ns |
| DI hold time | tын | 100 | - | - | ns |
| Data "1" output delay time | tPD1 | - | - | 200 | ns |
| Data "0" output delay time | t _{PD0} | - | - | 200 | ns |
| Time from CS to output establishment | tsv | - | - | 150 | ns |
| Time from CS to High-Z | tor | - | - | 150 | ns |
| Write cycle time | te/w | - | - | 5 | ms |

<u>(Ta=-40 ~ +85°C, Vcc=1.8 ~ 2.5V)</u>

| Parameter | Symbol | Min. | Тур. | Max. | Unit |
|--------------------------------------|-------------|------|------|------|------|
| SK frequency | fsк | - | - | 500 | kHz |
| SK "H" time | tsкн | 0.8 | - | - | μs |
| SK "L" time | tsĸ∟ | 0.8 | - | - | μs |
| CS "L" time | tcs | 1 | - | - | μs |
| CS setup time | tcss | 200 | - | - | ns |
| DI setup time | tois | 100 | - | - | ns |
| CS hold time | tсsн | 0 | - | - | ns |
| DI hold time | tын | 100 | - | - | ns |
| Data "1" output delay time | tpD1 | - | - | 0.7 | μs |
| Data "0" output delay time | tpd0 | - | - | 0.7 | μs |
| Time from CS to output establishment | tsv | - | - | 0.7 | μs |
| Time from CS to High-Z | t DF | - | - | 200 | ns |
| Write cycle time | te/w | - | - | 5 | ms |

• Sync data input / output timing

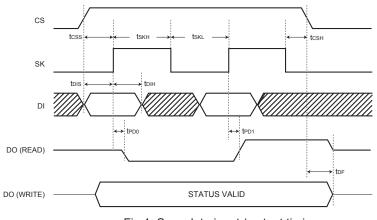
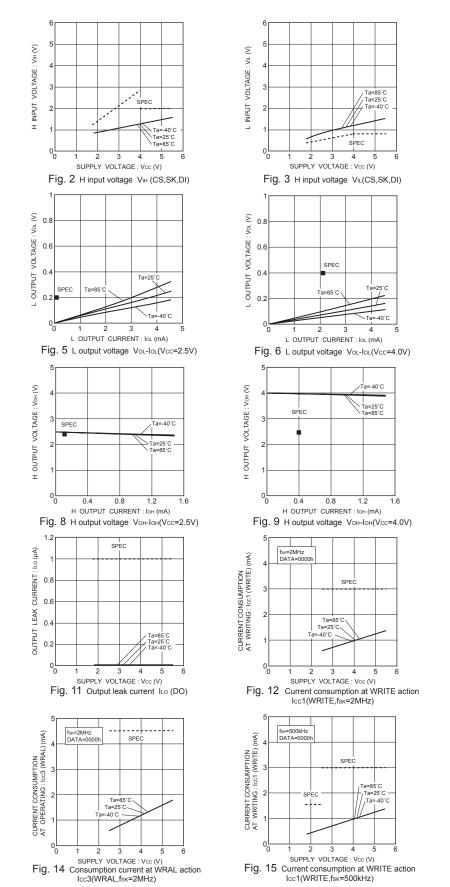
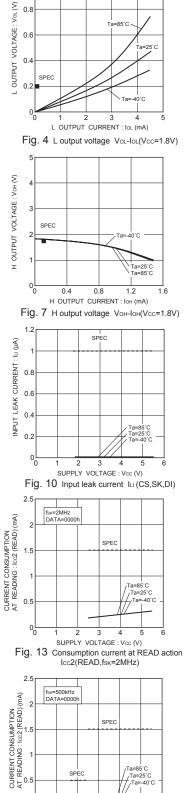


Fig.1 Sync data input / output timing

- \bigcirc Data is taken by DI in sync with the rise of SK.
- \bigcirc At read action, data is output from DO in sync with the rise of SK.
- The status signal at write (READY / BUSY) is output after tCS from the fall of CS after write command input, at the area DO where CS is "H", and valid until the next command start bit is input. And, while CS is "L", DO becomes High-Z.
- After completion of each mode execution, set CS "L" once for internal circuit reset, and execute the following action mode.

Characteristic data





0.8

85°C

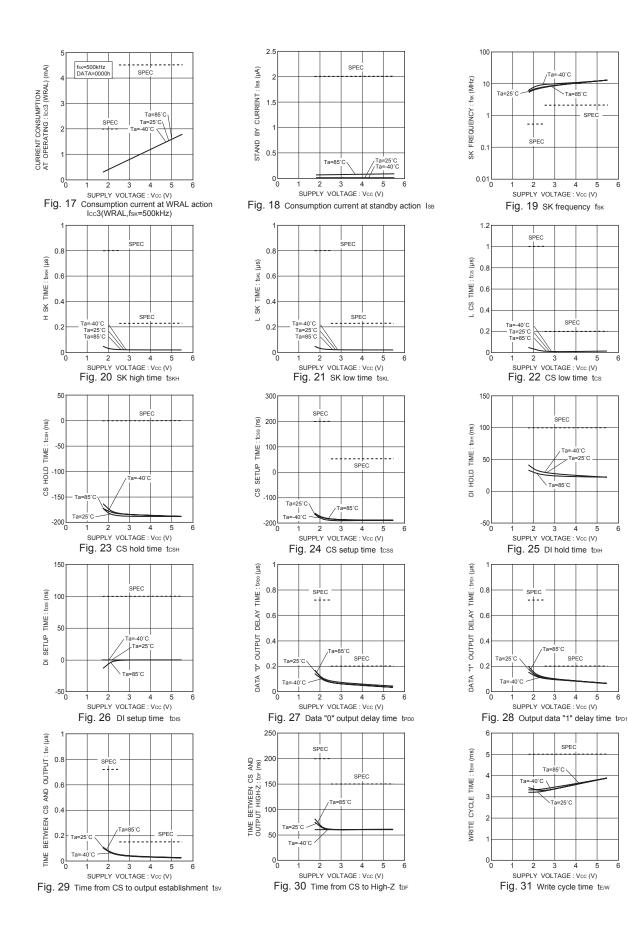
SUPPLY VOLTAGE : Vcc (V) Fig. 16 Consumption current at READ action Icc2(READ,fsk=500kHz)

2

5 6

0' 0

4/16



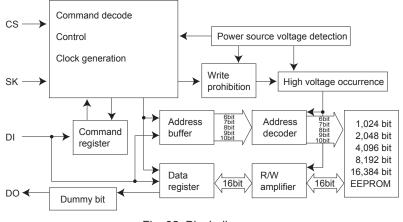
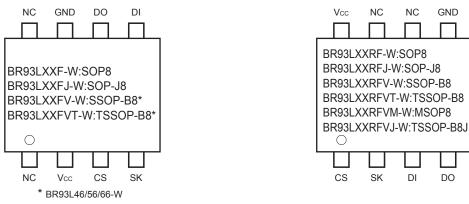


Fig. 32 Block diagram

Pin assignment and function





| Pin name | I/O | Function |
|----------|--------|--|
| Vcc | - | Power source |
| GND | - | All input / output reference voltage, 0V |
| CS | Input | Chip select input |
| SK | Input | Serial clock input |
| DI | Input | Start bit, ope code, address, and serial data input |
| DO | Output | Serial data output, READY / BUSY internal condition display output |
| NC | - | Non connected terminal, Vcc, GND or OPEN |

Description of operations

Communications of the Microwire Bus are carried out by SK (serial clock), DI (serial data input), DO (serial data output), and CS (chip select) for device selection.

When to connect one EEPROM to a microcontroller, connect it as shown in Fig. 34 (a) or Fig. 34 (b). When to use the input and output common I/O port of the microcontroller, connect DI and DO via a resistor as shown in Fig. 34 (b) (Refer to pages 13/16.), and connection by 3 lines is available.

In the case of plural connections, refer to Fig. 34 (c).

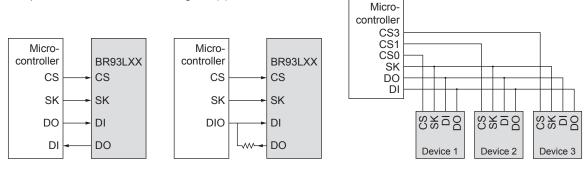


Fig. 34-(a) Connection by 4 lines Fig. 34-(b) Connection by 3 lines

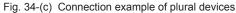


Fig. 34 Connection method with microcontroller

Communications of the Microwire Bus are started by the first "1" input after the rise of CS. This input is called a start bit. After input of the start bit, input ope code, address and data. Address and data are input all in MSB first manners.

"0" input after the rise of CS to the start bit input is all ignored. Therefore, when there is limitation in the bit width of PIO of the microcontroller, input "0" before the start bit input, to control the bit width.

| Command | | Start bit | One code | | Data | | |
|---------------------|----|-----------|----------|-----------------------|------------------------|-------------------------------|--------------------------|
| Commanu | | Start Dit | Ope code | BR93L46-W | BR93L56/66-W | BR93L76/86-W | Data |
| Read (READ) | *1 | 1 | 10 | A5,A4,A3,A2,A1,A0 A7, | 7,A6,A5,A4,A3,A2,A1,A0 | A9,A8,A7,A6,A5,A4,A3,A2,A1,A0 | D15 ~ D0 (READ DATA) |
| Write enable (WEN) | | 1 | 00 | 1 1 * * * * 1 | 1 * * * * * * | 1 1 * * * * * * * * | |
| Write (WRITE) | *2 | 1 | 01 | A5,A4,A3,A2,A1,A0 A7, | 7,A6,A5,A4,A3,A2,A1,A0 | A9,A8,A7,A6,A5,A4,A3,A2,A1,A0 | D15 ~ D0 (WRITE DATA) |
| Write all (WRAL) | *2 | 1 | 00 | 0 1 * * * * 0 | 1 * * * * * * | 0 1 * * * * * * * * | D15 ~ D0 (WRITE DATA) |
| Write disable (WDS) | | 1 | 00 | 0 0 * * * * 0 | 0 * * * * * * | 0 0 * * * * * * * * | |
| Erase (ERASE) | | 1 | 11 | A5,A4,A3,A2,A1,A0 A7, | 7,A6,A5,A4,A3,A2,A1,A0 | A9,A8,A7,A6,A5,A4,A3,A2,A1,A0 | |
| Chip erase (ERAL) | | 1 | 00 | 1 0 * * * * 1 | 0 * * * * * * | 10 * * * * * * * * | |

Input the address and the data in MSB first manners.As for *, input either VIH or VIL.

Command mode

* Start bit Acceptance of all the commands of this IC starts at recognition of the start bit. The start bit means the first "1" input after the rise of CS.

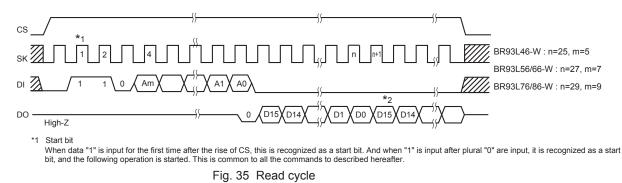
*1 As for read, by continuous SK clock input after setting the read command, data output of the set address starts, and address data in significant order are sequentially output continuously. (Auto increment function)

*2 When the read, and the write all commands are executed, data written in the selected memory cell is automatically deleted, and input data is written.

A7 of BR93L56-W becomes Don't Care. A9 of BR93L76-W becomes Don't Care.

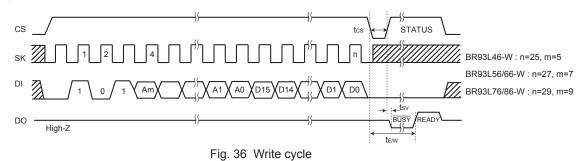
Timing chart

1) Read cycle (READ)



When the read command is recognized, input address data (16bit) is output to serial. And at that moment, at taking A0, in sync with the rise of SK, "0" (dummy bit) is output. And, the following data is output in sync with the rise of SK. This IC has address auto increment function valid only at read command. This is the function where after the above read execution, by continuously inputting SK clock, the above address data is read sequentially. And, during the auto increment, keep CS at "H".

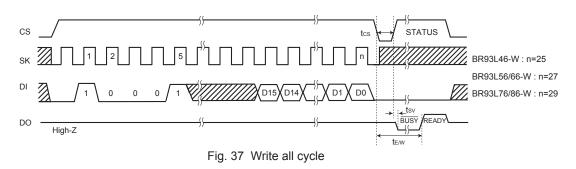
2) Write cycle (WRITE)



○ In this command, input 16bit data (D15 ~ D0) are written to designated addresses (Am ~ A0). The actual write starts by the fall of CS of D0 taken SK clock.

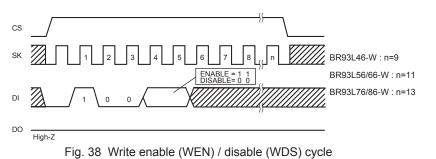
When STATUS is not detected, (CS = "L" fixed) Max. 5ms in conformity with tE/W, and when STATUS is detected (CS = "H"), all commands are not accepted for areas where "L" (BUSY) is output from D0, therefore, do not input any command.

3) Write all cycle (WRAL)

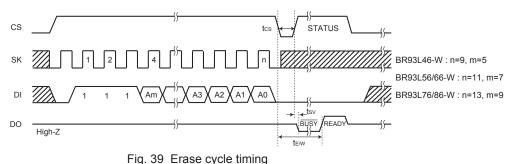


○ In this command, input 16bit data is written simultaneously to all addresses. Data is not written continuously per one word but is written in bulk, the write time is only Max. 5ms in conformity with tE/W.

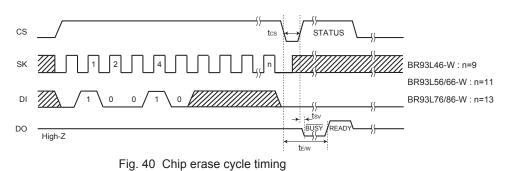
4) Write enable (WEN) / disable (WDS) cycle



- O At power on, this IC is in write disable status by the internal RESET circuit. Before executing the write command, it is necessary to execute the write enable command. And, once this command is executed, it is valid until the write disable command is executed or the power is turned off. However, the read command is valid irrespective of write enable / disable command. Input to SK after 6 clocks of this command is available by either "H" or "L", but be sure to input it.
- O When the write enable command is executed after power on, write enable status gets in. When the write disable command is executed then, the IC gets in write disable status as same as at power on, and then the write command is canceled thereafter in software manner. However, the read command is executable. In write enable status, even when the write command is input by mistake, write is started. To prevent such a mistake, it is recommended to execute the write disable command after completion of write.
- 5) Erase cycle timing (ERASE)



- In this command, data of the designated address is made into "1". The data of the designated address becomes "FFFFh". Actual ERASE starts at the fall of CS after the fall of A0 taken SK clock.
 In ERASE, status can be detected in the same manner as in WRITE command.
- 6) Chip erase cycle timing (ERAL)



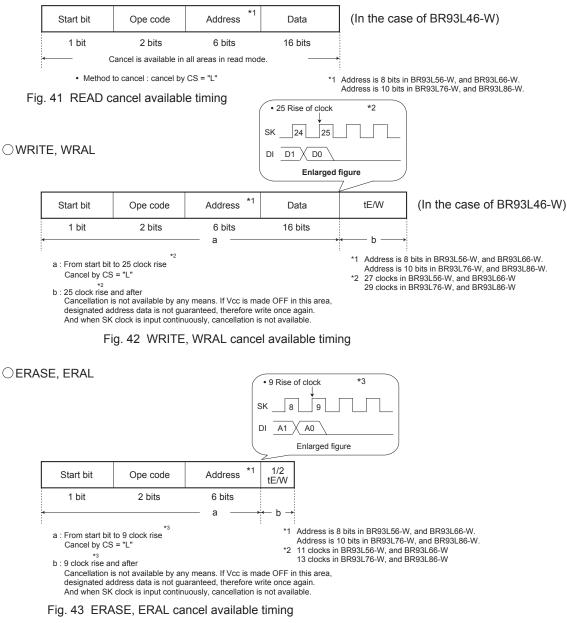
○ In this command, data of all addresses is erased. Data of all addresses becomes "FFFFh". Actual ERASE starts at the fall of CS after the fall of the n-th clock from the start bit input.

In ERAL, status can be detected in the same manner as in WRITE command.

Application

1) Method to cancel each command

\bigcirc READ

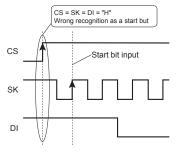


2) At standby

\bigcirc Standby current

When CS is "L", SK input is "L", DI input is "H", and even with middle electric potential, current does not increase.

As shown in Fig. 44, when SK at standby is "H", if CS is started, DI status may be read at the rise edge. At standby and at power ON/OFF, when to start CS, set SK input or DI input to "L" status. (Refer to Fig. 45.)



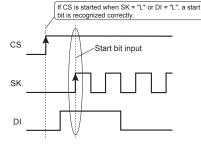
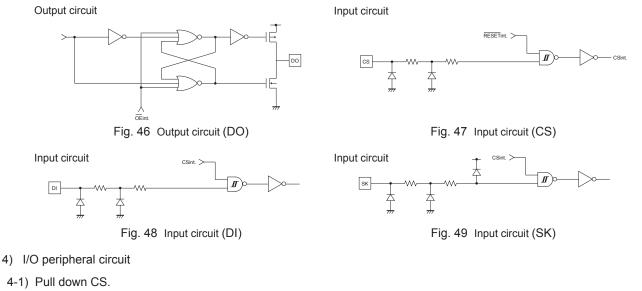


Fig. 44 Wrong action timing





By making CS = "L" at power ON/OFF, mistake in operation and mistake write are prevented.

○ Pull down resistance Rpd of CS pin

To prevent mistake in operation and mistake write at power ON/OFF, CS pull down resistance is necessary. Select an appropriate value to this resistance value from microcontroller VOH, IOH, and VIL characteristics of this IC.

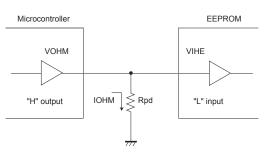


Fig. 50 CS pull down resistance

Rpd ≥ <u>VOHM</u> ... ①IOHM ≥ VIHE ... ②

Example) When Vcc = 5V, VIHE = 2V, VOHM = 2.4V, IOHM = 2mA, from the equation (1),

$$\mathsf{Rpd} \geq \frac{2.4}{2 \times 10^{-3}}$$

With the value of Rpd to satisfy the above equation, VOHM becomes 2.4V or higher, and with VIHE (= 2.0V), the equation 2 is also satisfied.

• VIHE : EEPROM VIH specifications

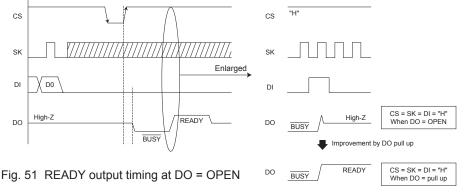
- VOHM : Microcontroller VOH specifications
- IOHM : Microcontroller IOH specifications
- 4-2) DO is available in both pull up and pull down.

DO output become "High-Z" in other READY / BUSY output timing than after data output at read command and write command.

When malfunction occurs at "High-Z" input of the microcontroller port connected to DO, it is necessary to pull down and pull up DO.

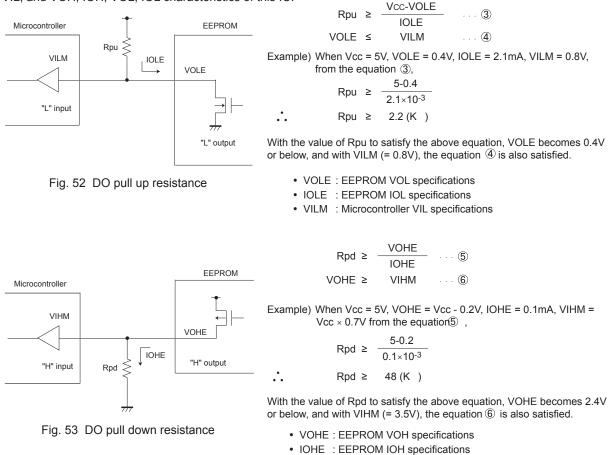
When there is no influence upon the microcontroller actions, DO may be OPEN.

If DO is OPEN, and at timing to output status READY, at timing of CS = "H", SK = "H", DI = "H", EEPROM recognizes this as a start bit, resets READY output, and DO = "High-Z", therefore, READY signal cannot be detected. To avoid such output, pull up DO pin for improvement.



OPull up resistance Rpu and pull down resistance Rpd of DO pin

As for pull up and pull down resistance value, select an appropriate value to this resistance value from microcontroller VIH, VIL, and VOH, IOH, VOL, IOL characteristics of this IC.



- VIHM : Microcontroller VIH specifications
- 5) READY / BUSY status display (DO terminal) (common to BR93L46-W, BR93L56-W, BR93L66-W, BR93L76-W, BR93L86-W)

This display outputs the internal status signal. When CS is started after tCS (Min. 200ns) from CS fall after write command input, "H" or "L" is output.

 R/\overline{B} display = "L" (\overline{BUSY}) = write under execution

(D0 status) After the timer circuit in the IC works and creates the period of tE/W, this time circuit completes automatically. And write to the memory cell is made in the period of tE/W, and during this period, other command is not accepted.

 R/\overline{B} display = "H" (READY) = command wait status

Even after tE/W (Max. 5ms) from write of the memory cell, the following command is accepted. Therefore, CS = "H" in the period of tE/W, and when input is in SK, DI, malfunction may occur, therefore, DI = "L" in the area CS = "H". (Especially, in the case of shared input port, attention is required.)

* Do not input any command while status signal is output. Command input in BUSY area is cancelled, but command input in READY area is accepted. Therefore, status READY output is cancelled, and malfunction and mistake write may be made.

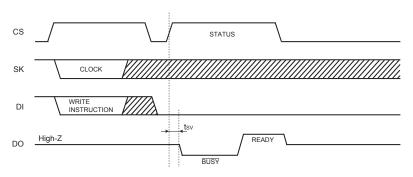


Fig. 54 R/B status output timing chart

6) When to directly connect DI and DO

This IC has independent input terminal DI and output terminal DO, and separate signals are handled on timing chart, meanwhile, by inserting a resistance R between these DI and DO terminals, it is possible to carry out control by 1 control line.

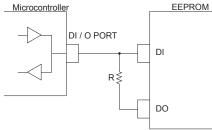


Fig. 55 DI, DO control line common connection

- O Data collision of microcontroller DI/O output and DO output and feedback of DO output to DI input Drive from the microcontroller DI/O output to DI input on I/O timing, and signal output from DO output occur at the same time in the following points.
 - 1 clock cycle to take in A0 address data at read command Dummy bit "0" is output to DO terminal.
 - \rightarrow When address data A0 = "1" input, through current route occurs.

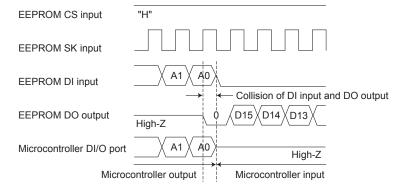


Fig. 56 Collision timing at read data output at DI, DO direct connection

(1) Timing of CS = "H" after write command. DO terminal in READY / BUSY function output.
 When the next start bit input is recognized, "HIGH-Z" gets in.
 →Especially, at command input after write, when CS input is started with microcontroller DI/O output "L", READY output "H" is output from DO terminal, and through current route occurs.

Feedback input at timing of these (1) and (2) does not cause disorder in basic operations, if resistance R is inserted.

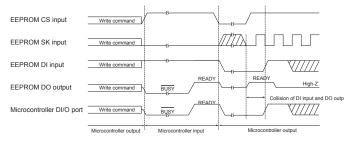


Fig. 57 Collision timing at DI, DO direct connection

Note) As for the case (2), attention must be paid to the following.

When status READY is output, DO and DO are shared, DI = "H" and the microcontroller DI/O = "High-Z" or the microcontroller DI/O = "H", if SK clock is input, DO output is input to DI and is recognized as a start bit, and malfunction may occur. As a method to avoid malfunction, at status READY output, set SK = "L", or start CS within 4 clocks after "H" of READY signal is output.

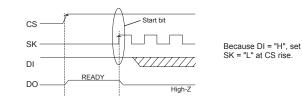


Fig. 58 Start bit input timing at DI, DO direct connection

O Selection of resistance value R

The resistance R becomes through current limit resistance at data collision. When through current flows, noises of power source line and instantaneous stop of power source may occur. When allowable through current is defined as I, the following relation should be satisfied. Determine allowable current amount in consideration of impedance and so forth of power source line in set. And insert resistance R, and set the value R to satisfy EEPROM input level VIH/VIL even under influence of voltage decline owing to leak current and so forth. Insertion of R will not cause any influence upon basic operations.

- (1) Address data A0 = "1" input, dummy bit "0" output timing
 - (When microcontroller DI/O output is "H", EEPROM DO outputs "L", and "H" is input to DI)
 - Make the through current to EEPROM 10mA or below.
 - · See to it that the input level VIH of EEPROM should satisfy the following.

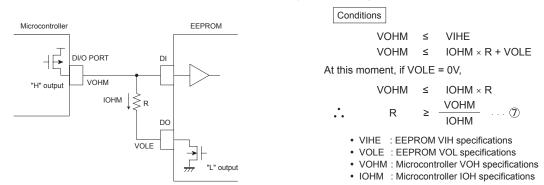


Fig. 59 Circuit at DI, DO direct connection (Microcontroller DI/O "H" output, EEPROM "L" output)

(2) DO status READY output timing

...

(When the microcontroller DI/O is "L", EEPROM DO outputs "H", and "L" is input to DI)

· Set the EEPROM input level VIL so as to satisfy the following.

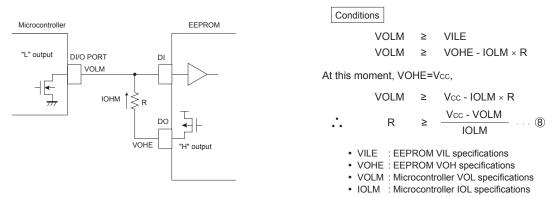


Fig. 60 Circuit at DI, DO direct connection (Microcontroller DI/O "L" output, EEPROM "H" output)

Example) When Vcc = 5V, VOHM = 5V, IOHM = 0.4mA, VOLM = 5V, IOLM = 0.4mA,

From the equation \mathcal{O} , From the equation (8), Vcc - VOLM VOHM R IOLM **IOHM** 5 - 0.45 R 0.4×10⁻³ 2.1×10⁻³ ... ≥ 2.2 [k] ... 10 R ≥ 12.5 [k] ... ⑨ R

Therefore, from the equations (9) and (10),

... R ≥ 12.5 [k]

7) Notes on power ON/OFF

• At power ON/OFF, set CS "L".

When CS is "H", this IC gets in input accept status (active). If power is turned on in this status, noises and the likes may cause malfunction, mistake write or so. To prevent these, at power ON, set CS "L". (When CS is in "L" status, all inputs are cancelled.) And at power decline, owing to power line capacity and so forth, low power status may continue long. At this case too, owing to the same reason, malfunction, mistake write may occur, therefore, at power OFF too, set CS "L".

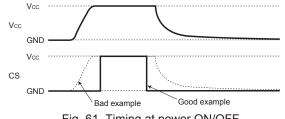


Fig. 61 Timing at power ON/OFF

(Bad example) CS pin is pulled up to Vcc.

(Good example) It is "L" at power ON/OFF.

In this case, CS becomes "H" (active status), and EEPROM may have malfunction, mistake write owing to noises and the likes. Even when CS input is High-Z, the status becomes like this case, which please note. Set 10ms or higher to recharge at power OFF. When power is turned on without observing this condition, IC internal circuit may not be reset, which please note.

OPOR circuit

This IC has a POR (Power On Reset) circuit as mistake write countermeasure.

After POR action, it gets in write disable status. The POR circuit is valid only when power is ON, and does not work when power is OFF. However, if CS is "H" at power ON/OFF, it may become write enable status owing to noises and the likes.

For secure actions, observe the following conditions.

1 Set CS = "L".

2 Turn on power so as to satisfy the recommended conditions of tR, tOFF, Vbot for POR circuit action.

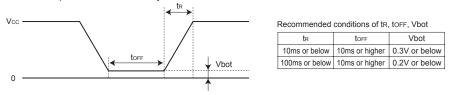


Fig. 62 Rise waveform diagram

⊖LVCC circuit

LVCC (Vcc - Lockout) circuit prevents data rewrite action at low power, and prevents wrong write. At LVCC voltage (Typ. = 1.2V) or below, it prevent data rewrite.

8) Noise countermeasures

○Vcc noise (bypass capacitor)

When noise or surge gets in the power source line, malfunction may occur, therefore, for removing these, it is recommended to attach a by pass capacitor (0.1 μ F) between IC Vcc and GND, At that moment, attach it as close to IC as possible.

And, it is also recommended to attach a bypass capacitor between board Vcc and GND.

⊖SK noise

When the rise time (tR) of SK is long, and a certain degree or more of noise exists, malfunction may occur owing to clock bit displacement. To avoid this, a Schmitt trigger circuit is built in SK input. the hysteresis width of this circuit is set about 0.2V, if noises exist at SK input, set the noise amplitude 0.2Vp-p or below.

And it is recommended to set the rise time (tR) of SK 100ns or below. In the case when the rise time is 100ns or higher, take sufficient noise countermeasures. Make the clock rise, fall time as small as possible.

Cautions on use

(1) Described numeric values and data are design representative values, and the values are not guaranteed.

- (2) We believe that application circuit examples are recommendable, however, in actual use, confirm characteristics further sufficiently. In the case of use by changing the fixed number of external parts, make your decision with sufficient margin in consideration of static characteristics and transition characteristics and fluctuations of external parts and our LSI.
- (3) Absolute Maximum Ratings

If the absolute maximum ratings such as impressed voltage and action temperature range and so forth are exceeded, LSI may be destructed. Do not impress voltage and temperature exceeding the absolute maximum ratings. In the case of fear exceeding the absolute maximum ratings, take physical safety countermeasures such as fuses, and see to it that conditions exceeding the absolute maximum ratings should not be impressed to LSI.

(4) GND electric potential

Set the voltage of GND terminal lowest at any action condition. Make sure that each terminal voltage is not lower than that of GND terminal in consideration of transition status.

(5) Heat design

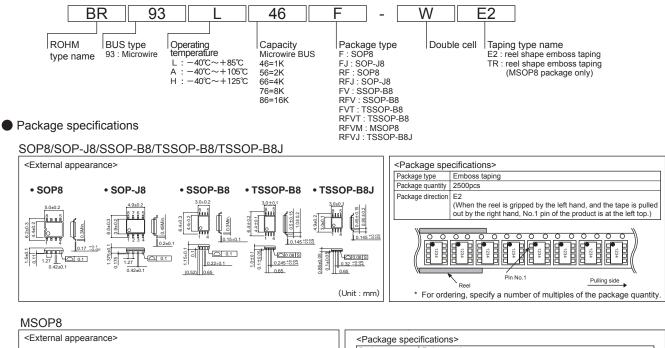
In consideration of allowable loss in actual use condition, carry out heat design with sufficient margin.

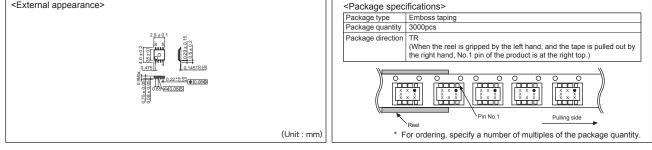
(6) Terminal to terminal shortcircuit and wrong packaging

When to package LSI onto a board, pay sufficient attention to LSI direction and displacement. Wrong packaging may destruct LSI. And in the case of shortcircuit between LSI terminals and terminals and power source, terminal and GND owing to foreign matter, LSI may be destructed.

(7) Use in a strong electromagnetic field may cause malfunction, therefore, evaluate design sufficiently.

Selection of order type





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